

8013-1156-1
PATENTS

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In the application of

Kenya KOBAYASHI

Confirmation No. 3586

Serial No. 10/607,064

Filed June 27, 2003

Examiner David A. Zarneke

METHOD OF FORMING A TRENCH ISOLATION

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

In compliance with Rules 1.97 and 1.98, and in fulfillment of the duty of disclosure under Rule 1.56, the accompanying documents, copies of which are attached to this statement, are made of record on the enclosed Form PTO-1449.

A concise explanation of the relevance of these items is that these references were cited by the Japanese Patent Office in the corresponding Japanese Application Serial No. 2000-286328, filed September 21, 2000. A copy of the Japanese Official Action in which they were cited is attached


S.N. 10/607,064

hereto, with what is believed to be the pertinent portion enclosed in a wavy line. An English translation of the enclosed portion is also attached hereto.

Respectfully submitted,

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By



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February 12, 2004

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO.
8013-1156-1

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10/607,064

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**
(Use several sheets if necessary)

37 CFR 1.98(b)

APPLICANT
Kenya KOBAYASHI

FILING DATE
June 27, 2003

GROUP
2812

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
	AI	A 5-55360	03/93	JP			with English abstract
	AJ	A 11-103033	04/99	JP			with English abstract
	AK	A 2002-26117	01/02	JP			with English abstract
	AL	A 4-3958	01/92	JP			with English abstract
	AO						
	AP						
	AQ						

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AT	
	AU	
	AV	
	AX	
	AY	

EXAMINER

DATE CONSIDERED

**EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered.
Include copy of this form with next communication to applicant.**